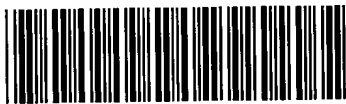


**Search Notes**

Application No.

09/902,855

Examiner

Tan V Mai

Applicant(s)

EPPIER ET AL.

Art Unit

2124

**SEARCHED**

Class	Subclass	Date	Examiner
708	200, 204, 552	8/24/2004	man

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Double Patenting Check Data Bases Search (see attached copy)	8/24/2004	man